Notice of References Cited Application/Control No. 10/501,429 Examiner Derick G. Jackson Applicant(s)/Patent Under Reexamination TIEKE ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

.*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,627,817	05-1997	Rosen et al.	369/100
*	В	US-2003/0185143 a1	10-2003	Lin et al.	369/275.4
*	С	US-2001/0005350 a1	06-2001	Kitaura et al.	369/94
*	D	US-6,511,788 b1	01-2003	Yasuda et al.	430/270.13
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	j	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Р	•				
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	R	·				
	S					
	Т					

NON-PATENT DOCUMENTS

7	*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	x						

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